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		First Named Inventor	SCARPA, ANDREA
		Group Art Unit	
		Examiner Name	
		Atty. Docket Number	NL040019US1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number No.-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS					
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NON-PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. ¹	Include name of the author (in capital letters), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ⁶
	1	DE MANARI I ET AL: "A TEST PATTERN FOR THREE-DIMENSIONAL LATCH-UP ANALYSIS"; MICROELECTRONIC TEST STRUCTURES 1993 ICMTS 1993; PROCEEDINGS OF THE 1993 INTERNATIONAL CONFERENCE ON SITGES, SPAIN 22-25 MARCH 1993; N.Y. USA; IEEE US 22 MARCH 1993; PP 103-109.			
	2	MUNARI DE ET AL: "DESIGN AND SIMULATION OF A TEST PATTERN FOR THREE-DIMENSIONAL LATCH-UP ANALYSIS"; MICROELECTRONICS JOURNAL MACKINTOSH PUBLICATIONS LTD; LUTON GB; VOL. 24, NO. 7; 1 NOV. 1993; PP 759-771.			

Examiner Signature	Date Considered
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.